

**Search Notes**

Application/Control No.

10/568,775

Examiner

Sikyin Ip

Applicant(s)/Patent under  
Reexamination

HIJII ET AL.

Art Unit

1742

**SEARCHED**

Class	Subclass	Date	Examiner
148	420		
420	407-410	12/30/2006	SI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
eDAN inventor names searched		
STN	12/30/2006	SI